

**Search Notes**

Application/Control No.

10/683,712

Examiner

Joseph Nguyen

Applicant(s)/Patent under  
Reexamination

BOGNER ET AL.

Art Unit

2815

**SEARCHED**

Class	Subclass	Date	Examiner
257	676, 684	10/12/2007	JN
257	706, 98	10/12/2007	JN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR